

# 30 V, 4.7 A NPN low V<sub>CEsat</sub> (BISS) transistor Rev. 01 — 1 April 2010

Product data sheet

#### 1. **Product profile**

### **1.1 General description**

NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a medium power and flat lead SOT89 (SC-62) Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS4032PX.

### 1.2 Features and benefits

- Very low collector-emitter saturation voltage V<sub>CEsat</sub>
- Optimized switching time
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (h<sub>FE</sub>) at high I<sub>C</sub>
- High energy efficiency due to less heat generation
- AEC-Q101 qualified
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

### 1.4 Quick reference data

#### Table 1. **Quick reference data**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	30	V
I <sub>C</sub>	collector current		-	-	4.7	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-	10	A
R <sub>CEsat</sub>	collector-emitter saturation resistance	I <sub>C</sub> = 4 A; I <sub>B</sub> = 400 mA	<u>[1]</u> -	45	62.5	mΩ

[1] Pulse test:  $t_p \le 300 \ \mu s$ ;  $\delta \le 0.02$ .



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## 2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	collector		2 J
3	base		3

## 3. Ordering information

Table 3. Order	ing inform	ation	
Type number	Package		
	Name	Description	Version
PBSS4032NX	SC-62	plastic surface-mounted package; 3 leads	SOT89

## 4. Marking

Table 4. Marking codes	
Type number	Marking code <sup>[1]</sup>
PBSS4032NX	*6H
<ul> <li>* = -: made in Hong Kong</li> <li>* = p: made in Hong Kong</li> </ul>	

- \* = p: made in Hong Kong
- \* = t: made in Malaysia
- \* = W: made in China

## 5. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter	-	30	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	30	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	5	V
I <sub>C</sub>	collector current		-	4.7	А
I <sub>CM</sub>	peak collector current	single pulse; $t_p \leq 1 ms$	-	10	A
IB	base current		-	1	А

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Table 5.	Limiting v	alues	continued
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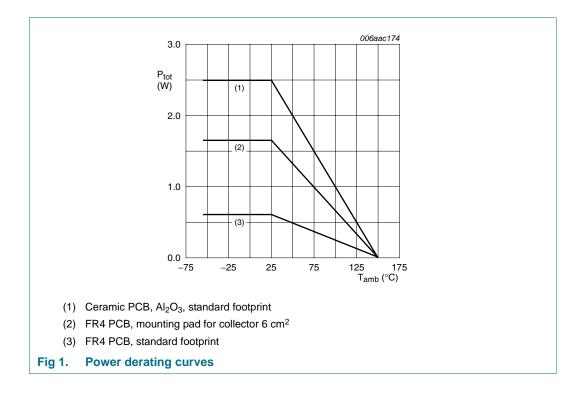
In accordance with the Absolute Maximum Rating System (IEC 60134).

SymbolParameterConditionsMinMaxUnit $P_{tot}$ total power dissipation $T_{amb} \le 25 \ ^{\circ}C$ $\boxed{11}$ -600mW	
	t
	1
[ <u>2]</u> - 1650 mW	1
[ <u>3]</u> - 2500 mW	1
$T_j$ junction temperature - 150 °C	
$T_{amb}$ ambient temperature $-55$ +150 °C	
$T_{stg}$ storage temperature -65 +150 °C	

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[3] Device mounted on a ceramic PCB,  $AI_2O_3$ , standard footprint.



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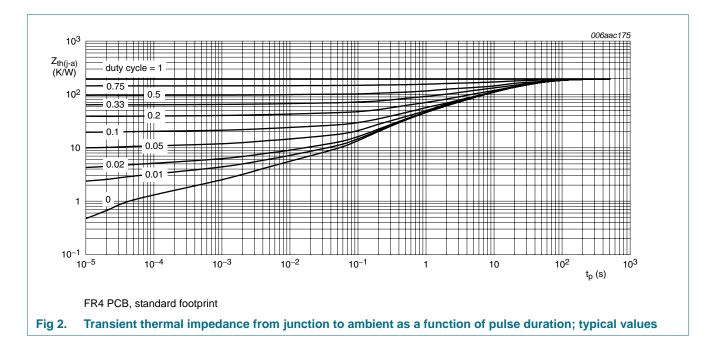
### 6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-a)</sub>	thermal resistance from	in free air	<u>[1]</u> _	-	210	K/W
	junction to ambient		[2] _	-	75	K/W
			<u>[3]</u> _	-	50	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		-	-	20	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

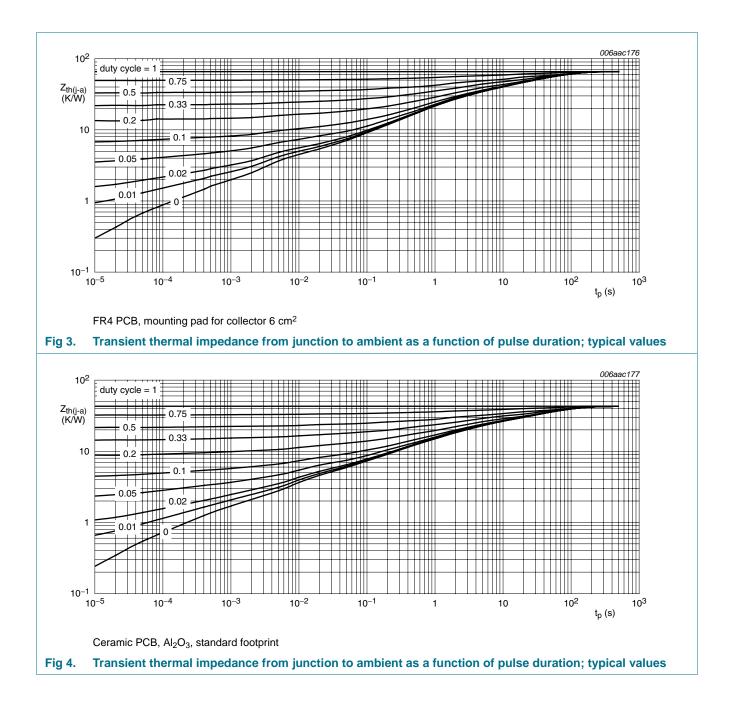
[3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



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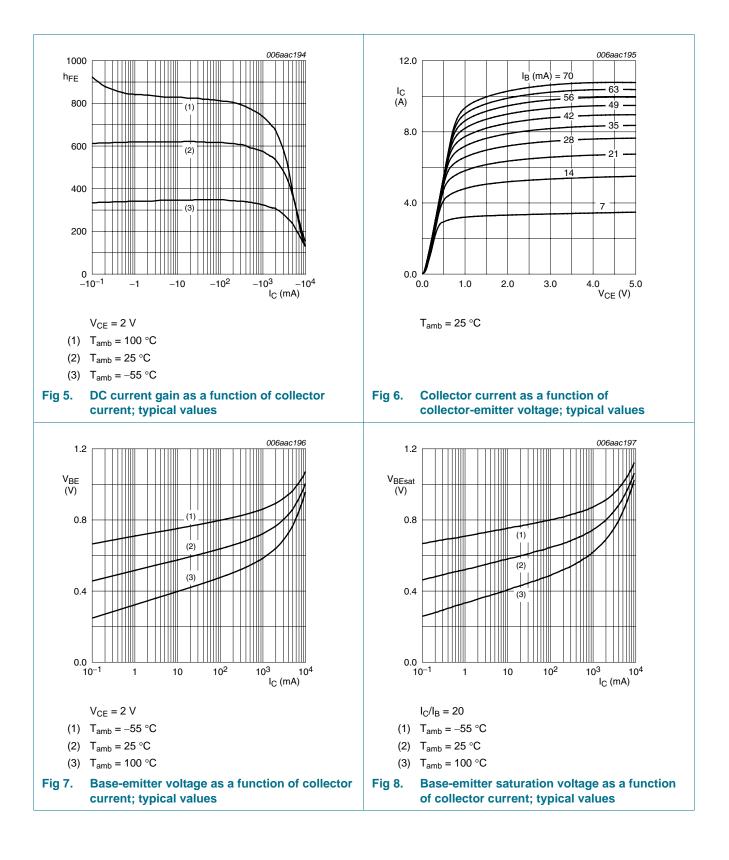
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## 7. Characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base cut-off	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A}$		-	-	100	nA
	current	$V_{CB} = 30 \text{ V}; I_E = 0 \text{ A};$ T <sub>j</sub> = 150 °C		-	-	50	μA
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = 24 \text{ V};  V_{BE} = 0 \text{ V}$		-	-	100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$		-	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 2 V$	[1]				
		I <sub>C</sub> = 500 mA		300	500	-	
		I <sub>C</sub> = 1 A		300	500	-	
		I <sub>C</sub> = 2 A		250	450	-	
		$I_{\rm C} = 4$ A		200	350	-	
		I <sub>C</sub> = 6 A		150	275	-	
V <sub>CEsat</sub>	collector-emitter		[1]				
	saturation voltage	I <sub>C</sub> = 1 A; I <sub>B</sub> = 50 mA		-	90	125	mV
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 10 mA		-	130	180	mV
		$I_{C} = 2 \text{ A}; I_{B} = 40 \text{ mA}$		-	150	210	mV
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 400 mA		-	180	250	mV
	$I_{C} = 4 \text{ A}; I_{B} = 40 \text{ mA}$		-	250	375	mV	
		I <sub>C</sub> = 5.4 A; I <sub>B</sub> = 270 mA		-	240	340	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	<u>[1]</u>	-	45	62.5	mΩ
V <sub>BEsat</sub>	base-emitter	I <sub>C</sub> = 1 A; I <sub>B</sub> = 100 mA	[1]	-	0.75	0.9	V
	saturation voltage	$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	0.92	1.05	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	<u>[1]</u>	-	0.77	0.85	V
t <sub>d</sub>	delay time	$V_{CC}$ = 12.5 V; I <sub>C</sub> = 1 A;		-	35	-	ns
t <sub>r</sub>	rise time	$I_{Bon} = 0.05 \text{ A};$		-	30	-	ns
t <sub>on</sub>	turn-on time	$I_{Boff} = -0.05 \text{ A}$		-	65	-	ns
t <sub>s</sub>	storage time			-	150	-	ns
t <sub>f</sub>	fall time			-	65	-	ns
t <sub>off</sub>	turn-off time			-	215	-	ns
f <sub>T</sub>	transition frequency	V <sub>CE</sub> = 10 V; I <sub>C</sub> = 100 mA; f = 100 MHz		-	145	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	65	-	pF

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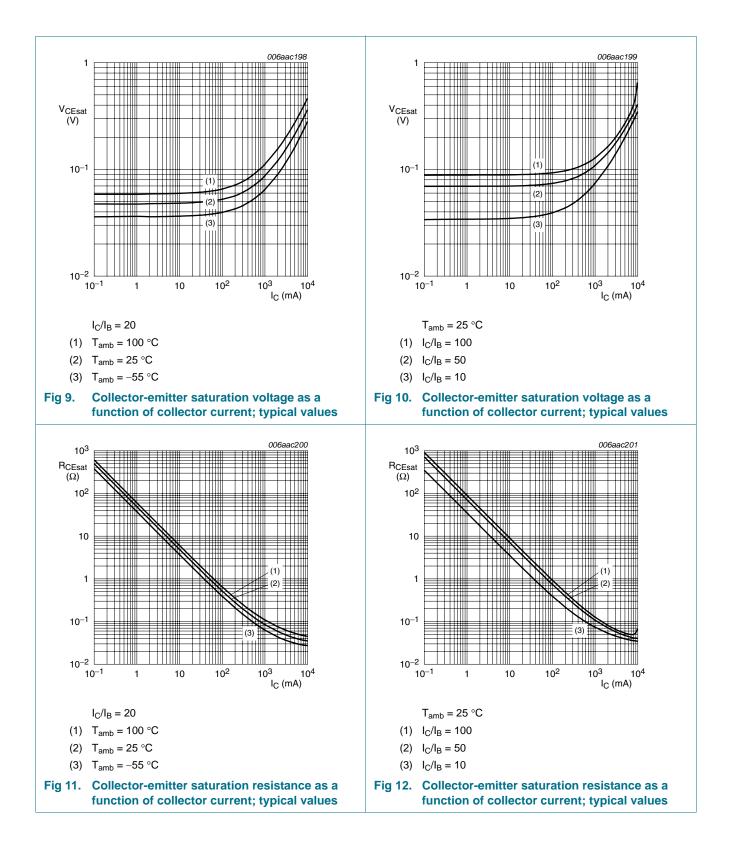


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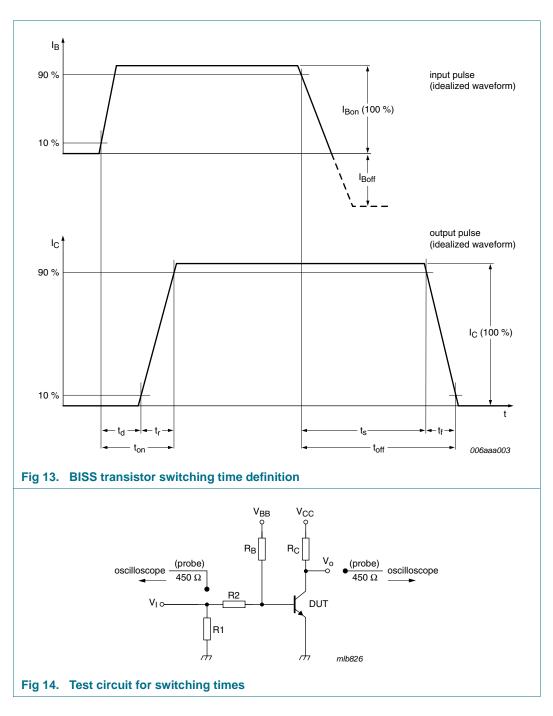
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## 8. Test information

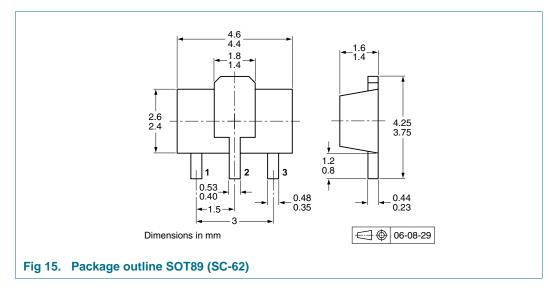


### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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### 9. Package outline



## **10. Packing information**

#### Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

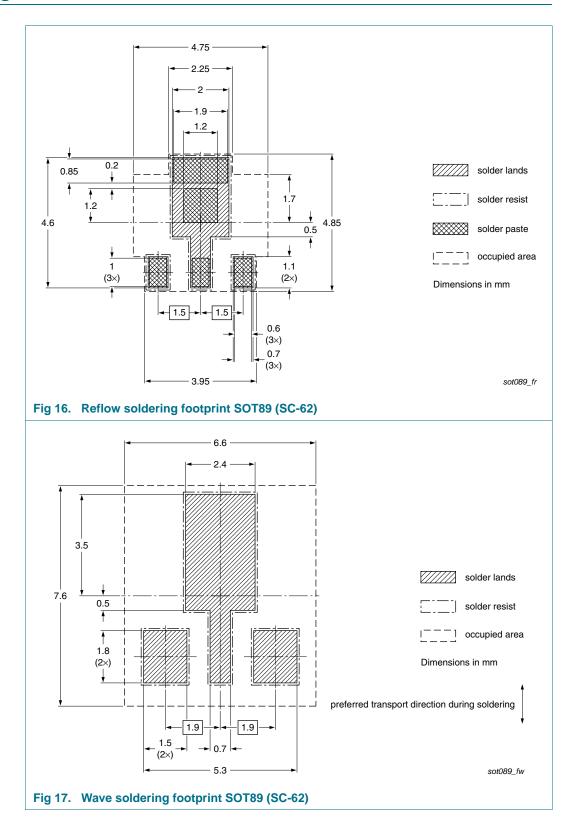
Type number	Package	Description F		Packing quantity	
				3000	10000
PBSS4032NX	SOT89	8 mm pitch, 12 mm tape and reel; T1	[2]	-115	-135
		8 mm pitch, 12 mm tape and reel; T3	<u>[3]</u>	-120	-

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

- [2] T1: normal taping
- [3] T3: 90° rotated taping

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## 11. Soldering



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## **12. Revision history**

Table 9. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4032NX_1	20100401	Product data sheet	-	-

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## 13. Legal information

### 13.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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For sales office addresses, please send an email to: salesaddresses@nxp.com

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